

<b>FORM PTO-1449</b> <b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>  <b>LIST OF REFERENCES CITED BY APPLICANT</b>  <i>(Use several sheets if necessary)</i>	<b>ATTORNEY DOCKET NO.</b> 1095.1211	<b>APPLICATION NO.</b>
	<b>FIRST NAMED INVENTOR</b> Haruo FUJIWARA	
	<b>FILING DATE</b> February 12, 2002	<b>GROUP ART UNIT</b>

### U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

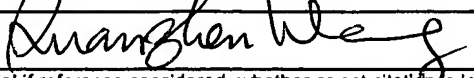
1095.1211 U.S. PTC  
 10/073195  
 02/13/02

### FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
QZW	AG	03205929 A	9/9/91	Japan			Abst	
QZW	AH	03042927 A	2/25/91	Japan			Abst	
	AI							
	AJ							
	AK							
	AL							

### OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AM	
	AN	
	AO	

<b>EXAMINER</b> 	<b>DATE CONSIDERED</b> 1/4/05
<small>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>	



Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

1095.1211

APPLICATION NO.

10/073,195

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR

Haruo FUJIWARA

FILING DATE

February 13, 2002

GROUP ART UNIT

2633

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
QZW	AG	1 122 898	8/8/01	European				
QZW	AH	0 935 356	8/11/99	European				
	AI							
	AJ							
	AK							
	AL							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

QZW	AM	United Kingdom Partial Search Report
QZW	AN	Japanese Abstract No. 2000 183820A, dated 6/30/00

EXAMINER

Shangzhen Wang

DATE CONSIDERED

1/4/05

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.